


<b>Search Notes</b>  	<b>Application/Control No.</b>  10511617	<b>Applicant(s)/Patent Under Reexamination</b>  SCHULTZ, JUERGEN
	<b>Examiner</b>  DEVONA E FAULK	<b>Art Unit</b>  2615

SEARCHED			
Class	Subclass	Date	Examiner
381	86,91,92	2/3/06	DEF
381	86,91,92	4/9/2008	DEF

SEARCH NOTES		
Search Notes	Date	Examiner
Assignee/Inventor search	2/3/07	DEF
Reviewed art submitted on IDS	2/3/07	DEF
Additional search	10/18/07	DEF
Reviewed applicant's arguments/maintained rejection	4/9/2008	DEF

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner